

# N-Channel 1200V (D-S) SiC Power MOSFET

PRODUCT SUMMARY			
V <sub>DS</sub> (V) at T <sub>J</sub> max.	1200		
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 18 V	0.021	
Q <sub>a</sub> (nC)	108		

### **FEATURES**

• Low figure-of-merit (FOM) Ron x Qa



- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

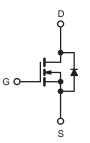
### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- DC/DC converter



TO-247-4L

- •Pin1 D Drain
- •Pin2 S Source(Power)
- •Pin3 S Source(Driver)
- •Pin4 G Gate



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	1200	V	
Gate-Source Voltage			$V_{GS}$	-10 / +22	V	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$V_{GS}$ at 18 V $T_{C} = 2$ $T_{C} = 10$	T <sub>C</sub> = 25 °C	Ι <sub>D</sub>	100		
Continuous Drain Current (1) = 130°C)		T <sub>C</sub> = 100 °C		70	Α	
Pulsed Drain Current a			I <sub>DM</sub>	300		
Linear Derating Factor				2.1	W/°C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	1200	mJ	
Maximum Power Dissipation			$P_D$	320	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		dV/dt 50		V/ns	
Reverse Diode dV/dt <sup>d</sup>			αν/αι	15	V/115	
Soldering Recommendations (Peak Temperature) c	(Peak Temperature) c for 10 s			260	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=100$  V, starting  $T_J=25$  °C, L = 30mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=9$ A.

- c. 1.6 mm from case. d.  $I_{SD} \le I_D$ , dl/dt = 100 A/ $\mu$ s, starting  $T_J$  = 25 °C.



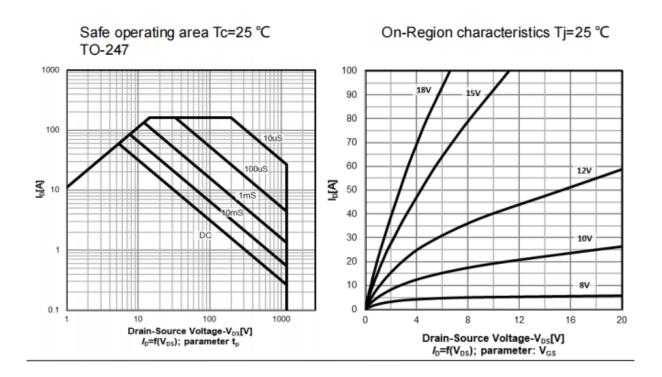
THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	•	0.47	C/VV	

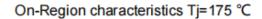
PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		*					
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 1 mA	1200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}$ , $I_D = 10 \text{ mA}$		-	4.5	V
		V <sub>GS</sub> = +22 V		-	-	100	nA
Gate-Source Leakage	$I_{GSS}$	,	V <sub>GS</sub> = -10 V		-	100	μΑ
	_	V <sub>DS</sub> =	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		10	-	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>				-	100	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 18 V	$I_D = 30A$	-	0.021	-	Ω
Forward Transconductance	9fs	V <sub>DS</sub>	s = 0 V, I <sub>D</sub> = 30 A	-	16	-	S
Dynamic		1			·	·	<u> </u>
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	2400	-	
Output Capacitance	Coss		$V_{DS} = 800 \text{ V},$	-	123	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		f = 1 MHz		10	-	pF
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V 0VI 000VV 00V		-	156	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	- V <sub>DS</sub> = 0 V	$V_{DS} = 0 \text{ V to } 800 \text{ V}, V_{GS} = 0 \text{ V}$		268	-	
Total Gate Charge	Qg			-	96		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = -5/18 V	$V_{GS} = -5/18 \text{ V}$ $I_D = 20 \text{ A}, V_{DS} = 800 \text{ V}$		29	-	nC
Gate-Drain Charge	$Q_{gd}$	1		ı	33	-	
Turn-On Delay Time	$t_{d(on)}$	V <sub>DD</sub> = 800 V, I <sub>D</sub> = 20A,		1	18	25	ns
Rise Time	t <sub>r</sub>			ı	24	55	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 0$	$V_{GS}$ = -5/18 V , $R_g$ = 2 $\Omega$		8 0	-	
Fall Time	t <sub>f</sub>				1 2	-	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		ı	3.2	-	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	100	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	300	- A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 30 A, V <sub>GS</sub> = 0		-	-	4.1	V
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 30 A, dI/dt = 1000 A/μs, V <sub>R</sub> = 800 V		-	60	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>			-	220	-	μC
Reverse Recovery Current	I <sub>RRM</sub>			_	60	_	A

### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .

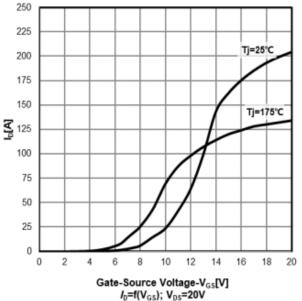






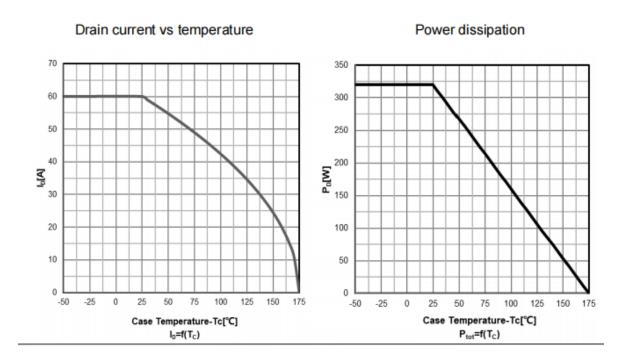
4 8 12 16 20 Drain-Source Voltage-V<sub>DS</sub>[V] I<sub>D</sub>=f(V<sub>DS</sub>); parameter: V<sub>GS</sub>

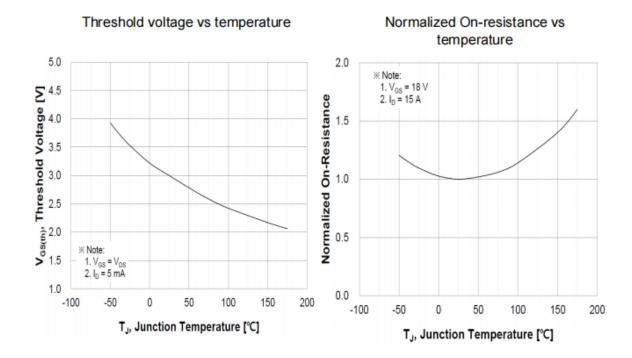
### Transfer characteristics



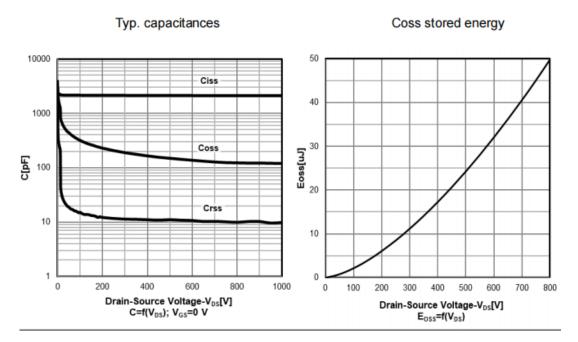
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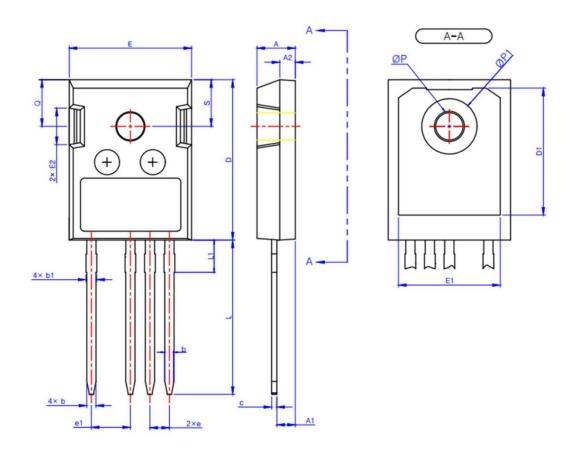


Typ. gate charge characteristics Diode forward voltage characteristics Tj=25 °C/175 °C 20 100V 15 200 800V 150 10 Tj=175°C 5 100 0 50 -5 0 -120 Source-Drain Voltage-V<sub>SD</sub>[V] Total Gate Charge-Qg[nC]  $V_{GS}$ =f(Q<sub>g</sub>),  $I_0$ =30 A pulsed Vgs=0V,I<sub>F</sub>=f(V<sub>SD</sub>); parameter: T<sub>j</sub>

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# TO-247-4L



### COMMON DIMENSIONS

COMMON BIMBINGTONS					
SYMBOL	UNIT(mm)				
SIMBOL	MIN	MAX			
A	4.80	5.20			
A1	2.29	2.54			
A2	1.90	2.10			
b	1.10	1.30			
b1	1.20	1.50			
c	0.50	0.70			
D	20.80	21.10			
D1	16.20	16.90			
E	15.75	16.15			
E1	13.06	13.86			
E2	4.23	4.83			
e	2.54BSC				
e1	5.08BSC				
${ m L}$	19.80	20.25			
L1	-	4.50			
ΦР	3.40	3.70			
ФР1	6.70	7.50			
Q	5.35	6.20			
S	6.15BSC				



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